FORM PTO-1449 MODIFIED				Serial No.			
List of Pate				Case No. CRM-P15F/P	10/628692		
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SEMT & THE			U.S. PATE	NT DOCUMENTS			
Examiner Initial	Do No	cument	Date	Name	Class	Subclass	
RD	4,7	70,860	9/88	Ewers et al			
	4,8	61,733	8/89	White			
	4,9	38,938	7/90	Ewers et al			
	5,2	90,558	3/94	O'Leary et al			
	5,3	52,715	10/94	Wallace et al			
	5,6	35,482	6/97	Bhatnagar			
5,676,976		10/97	Lee et al				
	5,840,290		11/98	Hench et al			
	5,9	22,025	7/99	Hubbard			
V	5,942,499		8/99	Radomsky			
		F	OREIGN PAT	ENT DOCUMENTS			
Examiner Initial	Document Date			Country	Translation YES NO		
RD	91/	17777	11/91	WO			
	, 99/	02107	1/99	WO :			
	99/	03487	1/99	wo			
	01/12247		2/01	wo			
V	1 0	1 080 737		EP			
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2001/0014664	RD	4/01	Radomsky				
2001/0053938	RD	12/01	Dorigatti et al				
2002/0136696	RD 9/02		Lee et al				
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RD	6,0	27,742	2/00	Lee et al			
 	6,0	6,030,635		Gertzmann et al			
	6,0	6,051,247		Hench et al		 	
	6,1	23,957	9/00	Jernberg		 	
	6,1	90,684	2/01	Hench et al			
	6,2	14,368	4/01	Lee et al		 	
	6,2	21,854	4/01	Radomsky			
6,		87,341	9/01	Lee et al			
, ,	6,428,803 6,432,436		8/03	Ewers et al			
. V			8/02	Hubbard			
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RD	631 499		5/01	EP			
		27 581	8/01	EP		//	
		903824	1/02	DE -		V	
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2002/0151466	RD	10/02	Hubbard et al				
2003/0143283 RI		7/03	Tofe				
2003/0049329	RĎ	3/03	Lee et al				
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DATE CONSIDERED

12/04/2006

/Ruth Davis/

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